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60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor Rev. 02 — 20 November 2009

Product data sheet

#### **Product profile** 1.

#### 1.1 General description

NPN low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a SOT89 (SC-62/TO-243) small and flat lead Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS304PX.

#### 1.2 Features

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Automotive applications

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	60	V
I <sub>C</sub>	collector current		-	-	4.7	Α
I <sub>CM</sub>	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	-	9.4	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = 4 \text{ A};$ $I_B = 200 \text{ mA}$	[1] -	37	53	mΩ

<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 



### 2. Pinning information

Table 2. Pinning

10010 21	9	
Pin	Description	Simplified outline Symbol
1	emitter	
2	collector	2
3	base	3 — 3 — 1 3 2 1 sym042

## 3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
PBSS304NX	SC-62	plastic surface-mounted package; collector pad for good heat transfer; 3 leads	SOT89			

## 4. Marking

Table 4. Marking codes

Type number	Marking code <sup>[1]</sup>
PBSS304NX	*5E

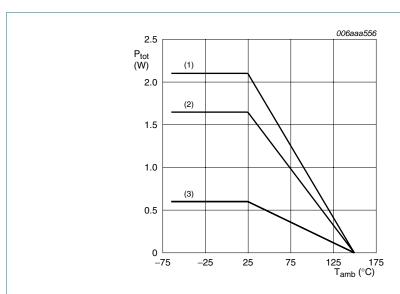
- [1] \* = -: made in Hong Kong
  - \* = p: made in Hong Kong
  - \* = t: made in Malaysia
  - \* = W: made in China

#### 5. **Limiting values**

Table 5. **Limiting values** In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	60	V
$V_{CEO}$	collector-emitter voltage	open base	-	60	V
$V_{EBO}$	emitter-base voltage	open collector	-	5	V
lc	collector current		-	4.7	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	9.4	Α
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	<u>[1]</u> -	0.6	W
			[2] _	1.65	W
			[3] _	2.1	W
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm<sup>2</sup>
- FR4 PCB, standard footprint

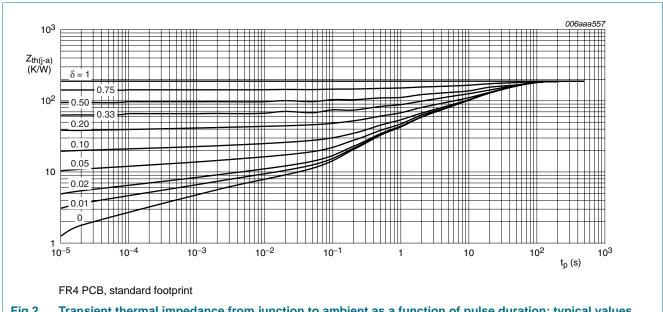
**Power derating curves** Fig 1.

#### Thermal characteristics 6.

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
ui(j-a)	thermal resistance from junction to ambient	[2]	[1]	-	-	208	K/W
			[2]	-	-	76	K/W
			[3]	-	-	60	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point			-	-	20	K/W

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



Transient thermal impedance from junction to ambient as a function of pulse duration; typical values Fig 2.

NXP Semiconductors PBSS304NX

60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor

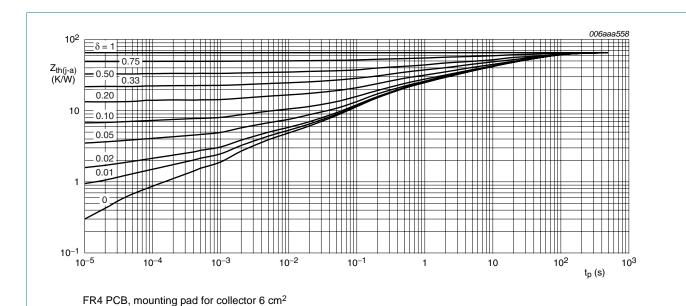


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

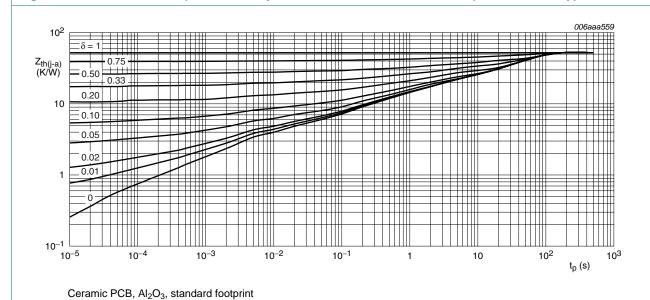


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

NXP Semiconductors PBSS304NX

60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor

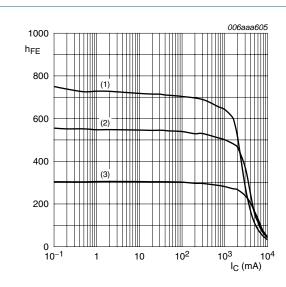
### 7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25$  °C unless otherwise specified.

amb — 20	C unless otherwise spec	iniou.				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>CBO</sub>	collector-base cut-off	$V_{CB} = 60 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
	current	$V_{CB} = 60 \text{ V; } I_E = 0 \text{ A;}$ $T_j = 150 \text{ °C}$	-	-	50	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 0.5 \text{ A}$	[1] 300	520	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 1 \text{ A}$	[1] 300	500	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	<sup>[1]</sup> 250	470	-	
	$V_{CE} = 2 \text{ V}; I_{C} = 4 \text{ A}$	<sup>[1]</sup> 150	250	-		
		$V_{CE} = 2 \text{ V}; I_{C} = 6 \text{ A}$	<u>[1]</u> 75	115	-	
$V_{CEsat}$	collector-emitter	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	<u>[1]</u> _	25	35	mV
	saturation voltage	$I_C = 1 A; I_B = 50 \text{ mA}$	<u>[1]</u> _	50	70	mV
		$I_C = 1 A; I_B = 10 mA$	<u>[1]</u> _	85	120	mV
	$I_C = 2 \text{ A}; I_B = 40 \text{ mA}$	<u>[1]</u> _	105	150	mV	
	$I_C = 4 \text{ A}; I_B = 200 \text{ mA}$	<u>[1]</u> _	145	210	mV	
	$I_C = 4 \text{ A}; I_B = 400 \text{ mA}$	<u>[1]</u> -	140	200	mV	
	$I_C = 4 \text{ A}; I_B = 80 \text{ mA}$	<u>[1]</u> -	190	290	mV	
		$I_C = 4.7 \text{ A}; I_B = 235 \text{ mA}$	[1] -	170	245	mV
R <sub>CEsat</sub>	collector-emitter	$I_C = 4 \text{ A}; I_B = 200 \text{ mA}$	[1] -	37	53	mΩ
	saturation resistance	$I_C = 4 \text{ A}; I_B = 80 \text{ mA}$	[1] -	48	73	mΩ
$V_{BEsat}$	base-emitter saturation	$I_C = 1 A$ ; $I_B = 100 \text{ mA}$	[1] -	0.82	0.9	V
	voltage	$I_C = 4 \text{ A}; I_B = 400 \text{ mA}$	[1] -	0.94	1.05	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	[1] -	0.75	0.85	V
t <sub>d</sub>	delay time	$V_{CC} = 12.5 \text{ V}; I_C = 3 \text{ A};$	-	15	-	ns
t <sub>r</sub>	rise time	I <sub>Bon</sub> = 0.15 A;	-	95	-	ns
t <sub>on</sub>	turn-on time	$I_{Boff} = -0.15 A$	-	110	-	ns
t <sub>s</sub>	storage time		-	360	-	ns
t <sub>f</sub>	fall time		-	195	-	ns
$t_{off}$	turn-off time		-	555	-	ns
f <sub>T</sub>	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 100 \text{ mA};$ f = 100 MHz	-	130	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	48	70	pF

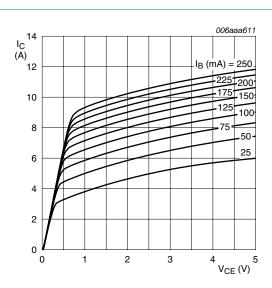
<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 



$$V_{CE} = 2 V$$

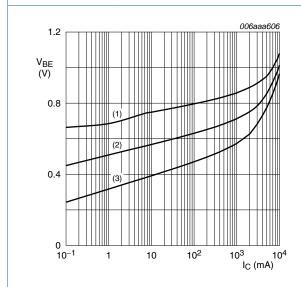
- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$ 

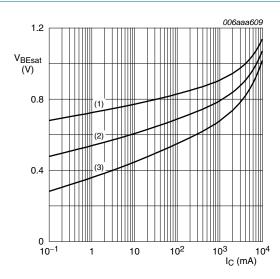
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \,^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

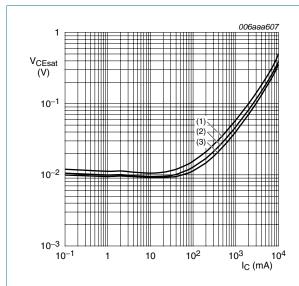
Fig 7. Base-emitter voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B}=20$$

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values



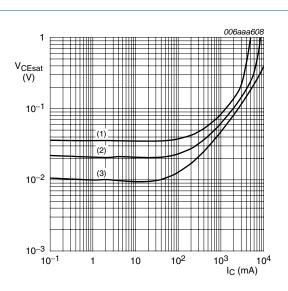
 $I_{\rm C}/I_{\rm B} = 20$ 

(1)  $T_{amb} = 100 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



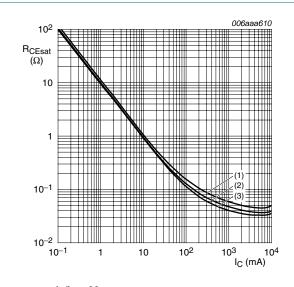
 $T_{amb} = 25 \, ^{\circ}C$ 

(1)  $I_C/I_B = 100$ 

(2)  $I_C/I_B = 50$ 

(3)  $I_C/I_B = 10$ 

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



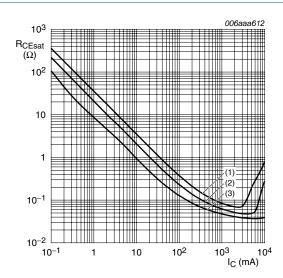
 $I_{\rm C}/I_{\rm B}=20$ 

(1)  $T_{amb} = 100 \, ^{\circ}C$ 

(2)  $T_{amb} = 25 \, ^{\circ}C$ 

(3)  $T_{amb} = -55 \, ^{\circ}C$ 

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

(1)  $I_C/I_B = 100$ 

(2)  $I_C/I_B = 50$ 

(3)  $I_C/I_B = 10$ 

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 8. Test information

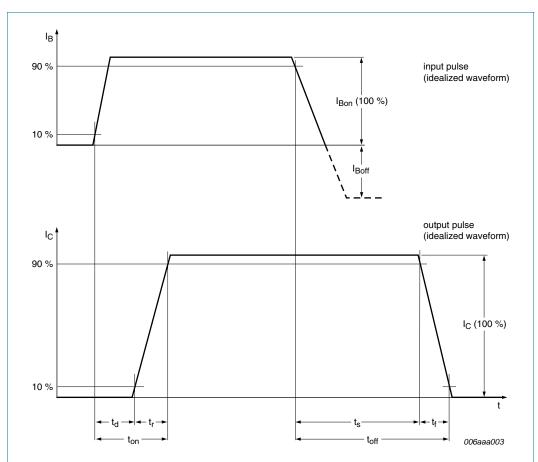
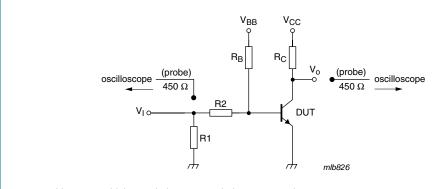


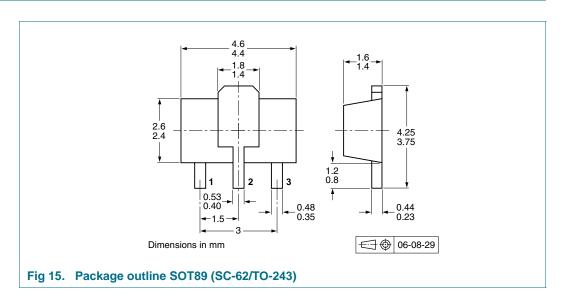
Fig 13. BISS transistor switching time definition



 $V_{CC} = 12.5 \text{ V}; I_C = 3 \text{ A}; I_{Bon} = 0.15 \text{ A}; I_{Boff} = -0.15 \text{ A}$ 

Fig 14. Test circuit for switching times

### 9. Package outline



### 10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

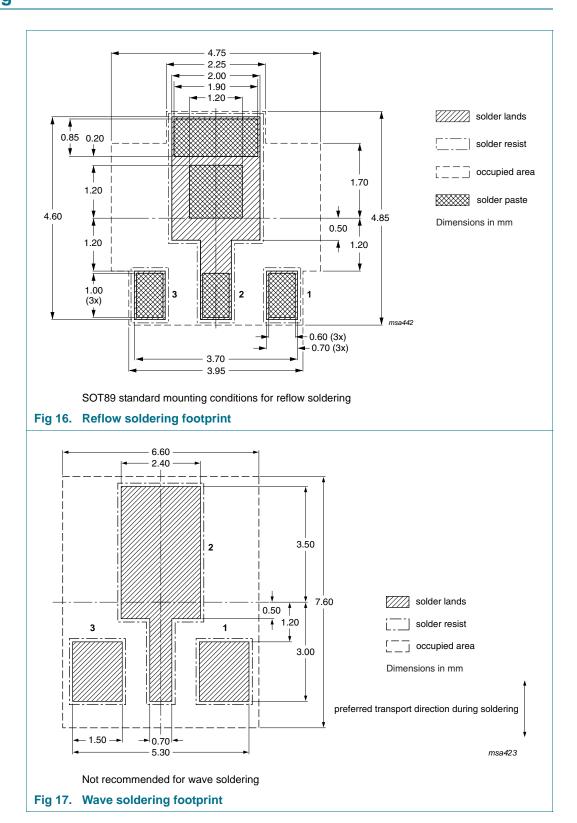
Type number	Package	Description	Packing qu	uantity
			1 000	4000
PBSS304NX	SOT89	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see  $\underline{\text{Section 15}}$ .

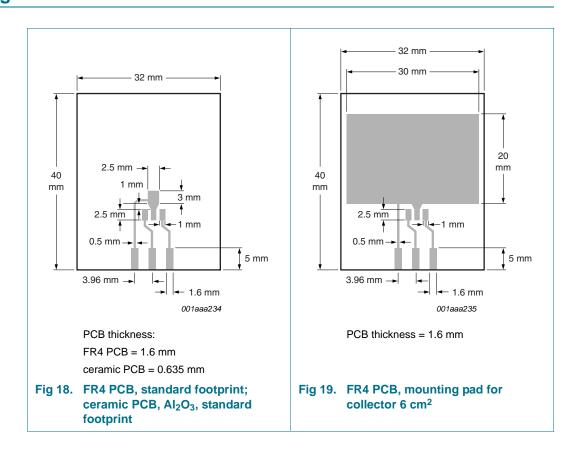
NXP Semiconductors PBSS304NX

60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 11. Soldering



### 12. Mounting



60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor

### 13. Revision history

### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS304NX_2	20091120	Product data sheet	-	PBSS304NX_1
Modifications:		was changed to reflect the egal definitions and disclair	, ,	•
	<ul> <li>Figure 15 "Pacl</li> </ul>	kage outline SOT89 (SC-62	2/TO-243)": updated	
	<ul> <li>Figure 16 "Refle</li> </ul>	ow soldering footprint": upo	lated	
	<ul><li>Figure 17 "Wav</li></ul>	e soldering footprint": upda	ated	
PBSS304NX_1	20060816	Product data sheet	-	-

### 14. Legal information

#### 14.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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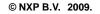
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60 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor

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